Daughter Board for Melexis PTC devices



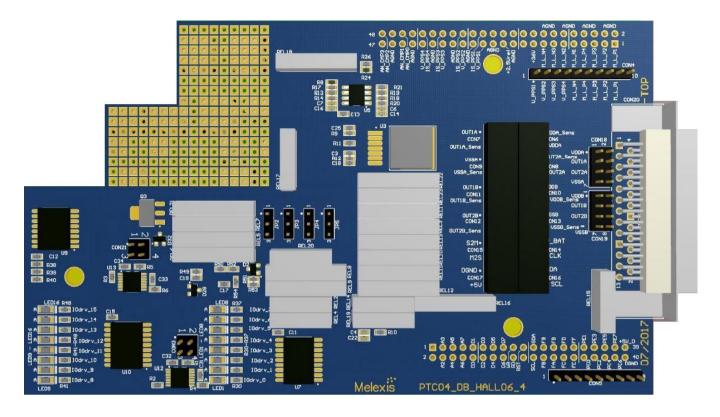


Figure 1: PTC04-DB-HALL06

Features and Benefits

PTC04 interface board for testing devices:

- MLX90371
- MLX90380
- MLX90372
- MLX91372
- MLX90373
- MLX90374
- MLX90378

Applications

Experimental tool for Lab and Prototyping Production Equipment for Serial Programming

Ordering Information

Part No.

PTC04-DB-Hall-06 V4.0

Description

Daughter Board (PCB + rear panel PTC04)

Accessories

Part No.

DLL's for all supported products User Interfaces for supported products Description



Functional Diagram

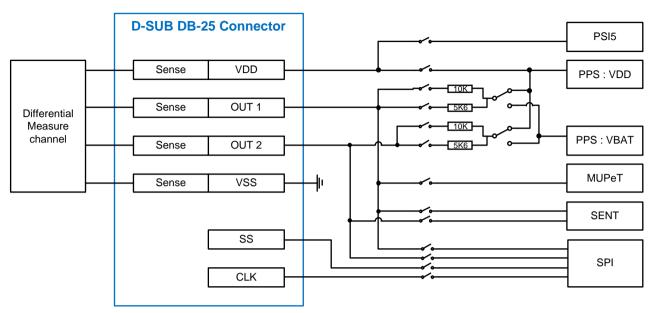


Figure 2: Functional diagram

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1. Board description

1.1. Board Layout

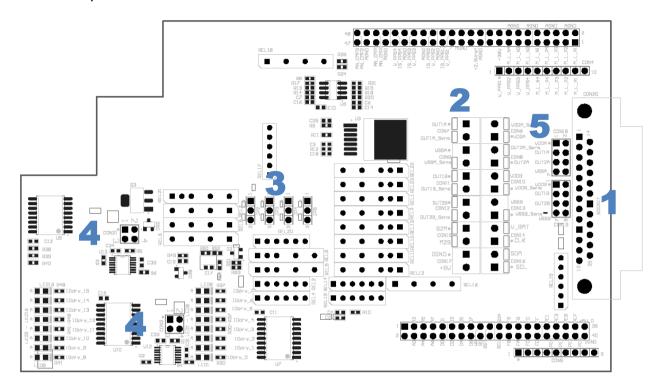


Figure 3: Top layer

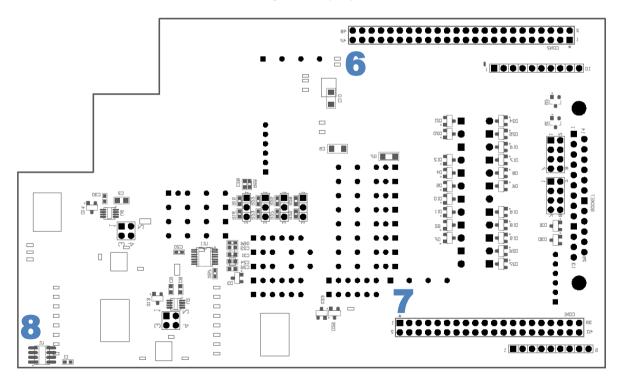


Figure 4: Bottom layer



- 1. DB-25 Connector (CON20): Connector to the application.
- 2. Screw terminal (CON7-16): Alternative connection to the application.
- 3. JP2, JP3, JP4, and JP5: Select 5K6 or 10 K for pull-up load to VDD or Vbat, resp. for OUT1A, OUT2A, OUT1B and OUT2B.
- 4. CON3 and CON21 Jumpers to select a 100 Ohm resistor or the digital potentiometer for MUPeT protocol.
- 5. CON18 and CON19 Jumpers to short the sensing lines at the device connector.
- 6. Analog (CON2) connector.
- 7. Digital (CON1) connector.
- 8. U1 This EEPROM memory keeps a few initial variables in mind. It allows for example to detect what DB is connected to the programmer and if the DB is not expired.

See below for a detailed description on the connectors and the jumper configurations.

1.2. Board Schematic

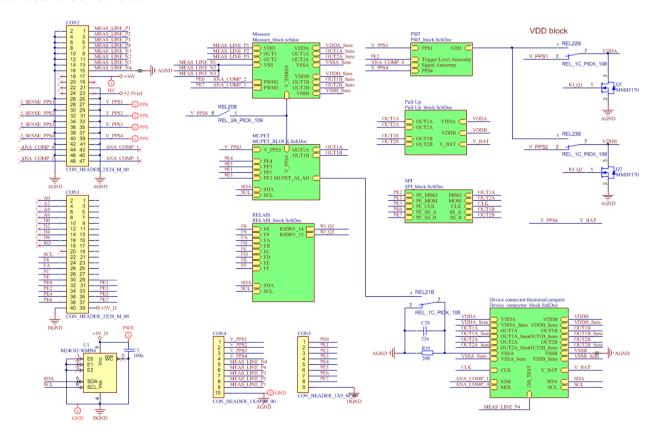


Figure 5: Main schematic



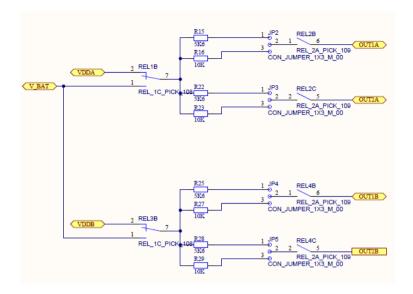


Figure 6: Pull-Up Block

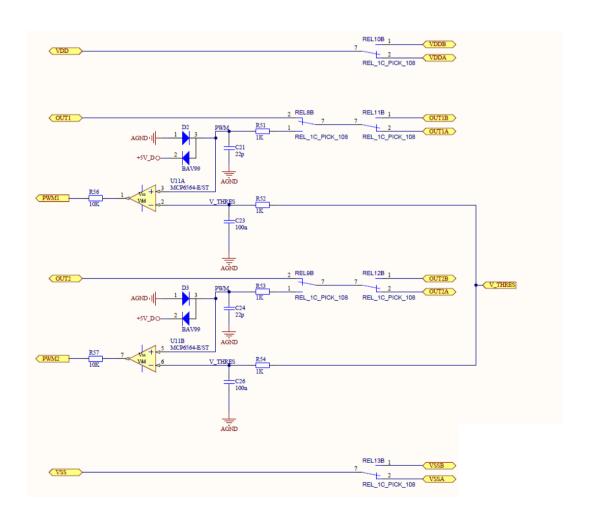


Figure 7: Measure Block



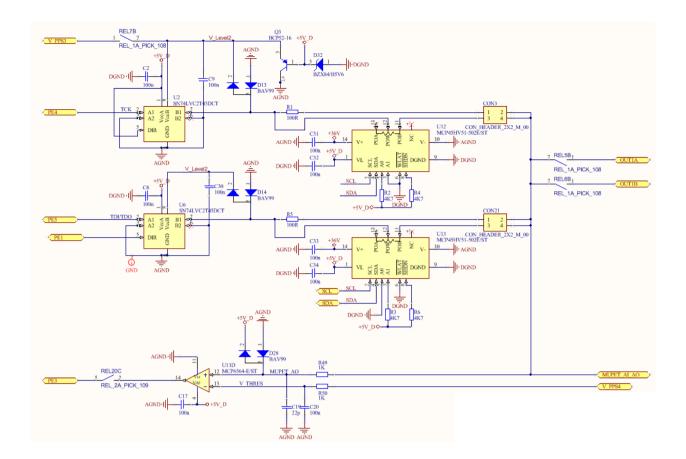


Figure 8: MUPET Block

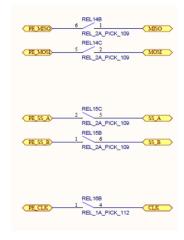


Figure 9: SPI Block



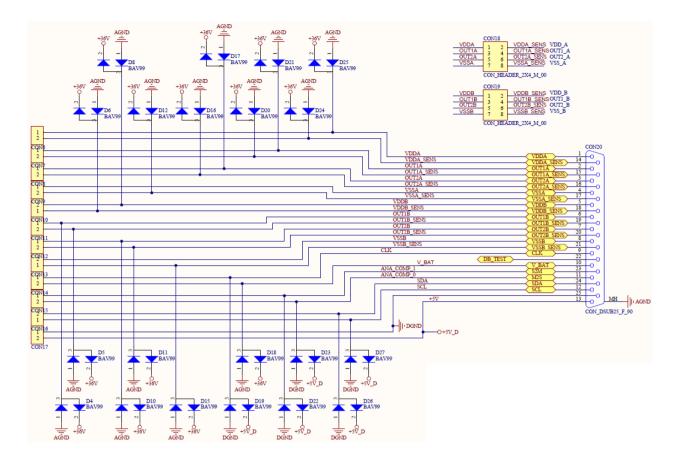


Figure 10: Device Connector Block

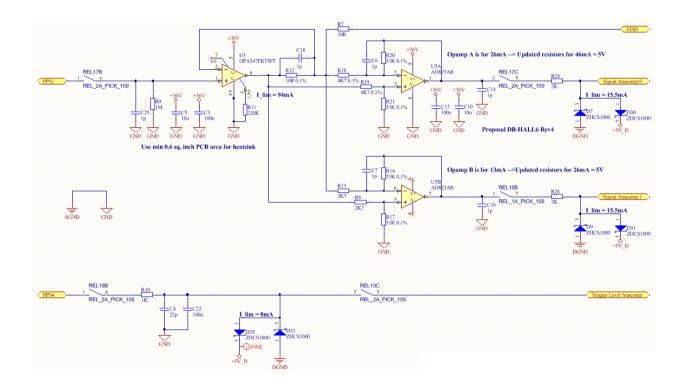


Figure 11: PSI5 Block



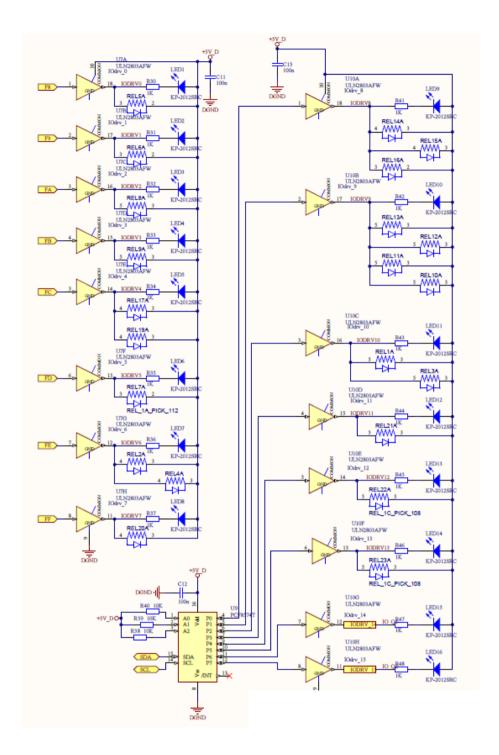


Figure 12: Relays Block



1.3. Daughter board Connectors

The main board has two connectors to the interface with the application. The PTC allows adding a full PCB in between. This daughter board can be mounted on the two connectors. In some exceptional cases, a daughter board contains only a few wires from the Analog connector to the application connector. The pins on of the connectors are described below.

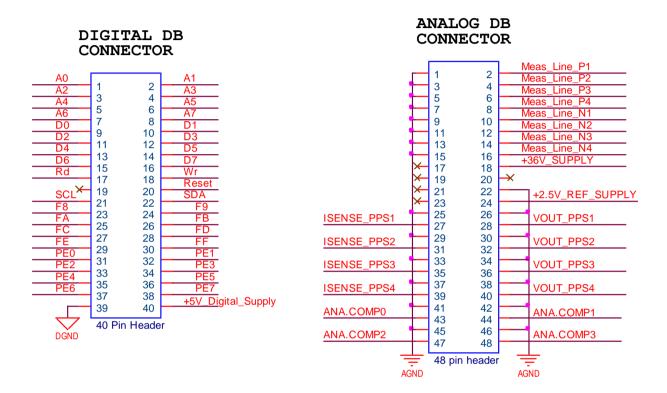


Figure 13: Daughter Board Connectors



1.3.1. Digital DB Connector (40 Pins)

Mainly, the digital connector is meant to expand the programmer to extra needs. Address lines AO-A7 together with the Map Select Lines F8-FF allows to direct access an area of 2 K. Examples would be adding a simple addressed I/O register by using the selection lines. If more complexity is needed, a full FPGA can be mounted on the DB board

Pins	Names	Description
1 – 8	A0 – A7	Address lines
9 – 16	D0 – D7	Data Lines active during Rd or Wr signals
17	Rd	Read: A negative pulse will indicate a sampling of the data on the Data Bus
18	Wr	Write: A Negative pulse will indicate when data is available on the Data Bus
20	Reset	This signal goes low by powering the PTC or by pressing the reset button. This line can be pulled low by application. Check firmware documentation for resetting by software.
21-22	SCL / SDA	12c Bus
23-30	F8,F9,,FF	CS lines when the address areas are accessed
31-38	Port E	Note: These pins are limited to 5 Volt input\output!!!! The full Port E of the Atmega core is mounted to these pins. This allows us to use advanced features like PWM, UARTS, Time Measurements, etc By using firmware that supports these, functions, application specific requirements can be fulfilled.
39	DGND	Digital Ground
40	+5V Digital	5 Volt Digital Supply. Maximum current to get out of this supply: 250mA

Note: All the pins are limited to 5 Volt input\output!!!! However, there are Protections, please take precautions in order to avoid damage of the main board.

1.3.2. Analog DB Connector (48 Pins)

Mainly, the analog connector provides all the analog signals and measure possibilities.

Pins	Names	Description
28,32,36	PPS 1-3	Output of the Programmable Supplies
40	PPS 4	Output of the Fast DAC Programmable Power Supply
27,31,35,39	Isense_PP1-4	Outputs (Driver outputs before Rsens) for current evaluations. These outputs could be used to connect to the analog comparators in order to create fast digital signals based on current.
2,4,6,8	ExtMeas1-4Pos	There are 4 differential inputs for making measurements
10,12,14,16	ExtMeas1_4Neg	The negative inputs of ExtMeas1-4Pos
17,19,21,23	Shtd_PPS1-4	Outputs that shows the status of the Drivers. Signals are meant to connect LED's to put the front panel
43,44,47,48	AnaComp0-3	Input (limited to 5V) See *Note. Fast Level comparators in order to remove time consuming measurement
18	+35V_Supply	Supply to extend the daughter board with some extra drivers
24	+2.5V Ref	Output of internal reference
All other	AGND	Analog Ground

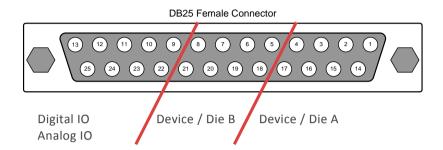
Note: All the pins are limited to 35 Volt input\output!!!! However, there are Protections, please take precautions in order to avoid damage of the main board.

^{*} Note: Some pins are protected and limited to 5 Volt!!!! However, there are Protections, please take precautions in order to avoid damage of the main board.



1.4. Application Connector

The figure and table below shows the connections as provided by the daughterboard PTC04-DB-HALL06. The view of the connector is front view for the female connector of the PTC04-DB-HALL06 which corresponds to the solder side of the male connector. The right side of the connector is used for device / die A, the left side of the connector is used for device / die B.



Additional, there are screw terminals on the Daughterboard that allows you to connect direct to wire.

PTC0	4			90371 9	90372 91372
D-SU	B 25			SO	TSSOP
Pin	Names	SPI	Description	Pin	Pin
1	VDDA	VDD	Supply Device A (Minimum required single die connection)	1	3
2	OUT1A	MOSI	Output 1 Device A (Minimum required single die connection)	5	15
3	OUT2A	MISO	Output 2 Device A		
4	VSSA	VSS	Analog Ground Device A (Minimum required single die connection)	8	2
5	VDDB		Supply Device B (Minimum required dual die connection ¹)		11
6	OUT1B	SS1	Output 1 Device B (Minimum required dual die connection)		6
7	OUT2B	SS2	Output 2 Device B		
8	VSSB		Analog Ground Device B (Minimum required dual die connection)		10
9		CLK	SPI CLOCK		
10	V_BAT		Programmable power supply (Max 30mA load)		
11	M2S		Digital IO		
12	SCL		I2C communication		
13	+5Vdig		Digital supply used for I2C devices		
14	VDDA_S		Sensing Supply Device A	1	3
15	OUT1A_S		Sensing Output 1 Device A	5	15
16	OUT2A_S		Sensing Output 2 Device A		
17	VSSA_S		Sensing Analog Ground Device A	8	2
18	VDDB_S		Sensing Supply Device B		11
19	OUT1B_S		Sensing Output 1 Device B		6
20	OUT2B_S		Sensing Output 2 Device B		
21	VSSB_S		Sensing Analog Ground Device B		10
22	DB_TEST		Free measuring line		
23	S2M		Digital IO		
24	SDA		I2C communication		
25	DGND		Digital ground for I2C communication		
MH	AGND		Metal Housing (shielding of the connector)		

¹ In case of a dual die connection with a common supply in the application (common VDD), only the VDDA pin of the daughter board device connector needs to be connected.

Daughter Board for Melexis PTC devices



PTC0	4			90371	90372
D CII	D OF			90372	DMD#3
D-SU	Names	SPI	Description	DMP#1 Pin	DMP#2 PIN
Pin			Description		
1	VDDA	VDD	Supply Device A (Minimum required single die connection)	2	3
2	OUT1A	MOSI	Output 1 Device A (Minimum required single die connection)	3	1
3	OUT2A	MISO	Output 2 Device A	4	2
4	VSSA	VSS	Analog Ground Device A (Minimum required single die connection)	4	2
5	VDDB		Supply Device B (Minimum required dual die connection ²)		
6	OUT1B	SS1	Output 1 Device B (Minimum required dual die connection)		
7	OUT2B	SS2	Output 2 Device B		
8	VSSB		Analog Ground Device B (Minimum required dual die connection)		
9		CLK	SPI CLOCK		
10	V_BAT		Programmable power supply (Max 30mA load)		
11	M2S		Digital IO		
12	SCL		I2C communication		
13	+5Vdig		Digital supply used for I2C devices		
14	VDDA_S		Sensing Supply Device A	2	3
15	OUT1A_S		Sensing Output 1 Device A	3	1
16	OUT2A_S		Sensing Output 2 Device A		
17	VSSA_S		Sensing Analog Ground Device A	4	2
18	VDDB_S		Sensing Supply Device B		
19	OUT1B_S		Sensing Output 1 Device B		
20	OUT2B S		Sensing Output 2 Device B		
21	VSSB S		Sensing Analog Ground Device B		
22	DB_TEST		Free measuring line		
23	S2M		Digital IO		
24	SDA		I2C communication		
25	DGND		Digital ground for I2C communication		
МН	AGND		Metal Housing (shielding of the connector)		

² In case of a dual die connection with a common supply in the application (common VDD), only the VDDA pin of the daughter board device connector needs to be connected.

Daughter Board for Melexis PTC devices



PTC0	4			90373	
D-SU	B 25			DMP	TSSOP
Pin	Names	SPI	Description	Pin	Pin
1	VDDA	VDD	Supply Device A (Minimum required single die connection)	2	3
2	OUT1A	MOSI	Output 1 Device A (Minimum required single die connection)		
3	OUT2A	MISO	Output 2 Device A		
4	VSSA	VSS	Analog Ground Device A (Minimum required single die connection)	4	2
5	VDDB		Supply Device B (Minimum required dual die connection ³)		11
6	OUT1B	SS1	Output 1 Device B (Minimum required dual die connection)		
7	OUT2B	SS2	Output 2 Device B		
8	VSSB		Analog Ground Device B (Minimum required dual die connection)		10
9		CLK	SPI CLOCK		
10	V_BAT		Programmable power supply (Max 30mA load)		
11	M2S		Digital IO		
12	SCL		I2C communication		
13	+5Vdig		Digital supply used for I2C devices		
14	VDDA_S		Sensing Supply Device A	2	3
15	OUT1A_S		Sensing Output 1 Device A		
16	OUT2A_S		Sensing Output 2 Device A		
17	VSSA_S		Sensing Analog Ground Device A	4	2
18	VDDB_S		Sensing Supply Device B		11
19	OUT1B_S		Sensing Output 1 Device B		
20	OUT2B_S		Sensing Output 2 Device B		
21	VSSB_S		Sensing Analog Ground Device B		10
22	DB_TEST		Free measuring line		
23	S2M		Digital IO		
24	SDA		I2C communication		
25	DGND		Digital ground for I2C communication		
MH	AGND		Metal Housing (shielding of the connector)		

³ In case of a dual die connection with a common supply in the application (common VDD), only the VDDA pin of the daughter board device connector needs to be connected.



Pin Names SPI Description Pin	PTC04				903	74	
Pin Names SPI Description Pin Pir Pir Pir Pin <						9	0378
1 VDDA VDD Supply Device A (Minimum required single die connection) 3 1 3 2 OUT1A MOSI Output 1 Device A (Minimum required single die connection) 1 5 15 3 OUT2A MISO Output 2 Device A 4 3 3 4 VSSA VSS Analog Ground Device A (Minimum required single die connection) 2 8 2 5 VDDB Supply Device B (Minimum required dual die connection) 7 1 <th>D-SUE</th> <th>3 25</th> <th></th> <th></th> <th>DMP</th> <th>SO</th> <th>TSSOP</th>	D-SUE	3 25			DMP	SO	TSSOP
OUT1A MOSI Output 1 Device A (Minimum required single die connection) OUT2A MISO Output 2 Device A VSSA VSS Analog Ground Device A (Minimum required single die connection) Supply Device B (Minimum required dual die connection) OUT1B SS1 Output 1 Device B (Minimum required dual die connection) OUT2B SS2 Output 1 Device B (Minimum required dual die connection) OUT2B SS2 Output 2 Device B (Minimum required dual die connection) CLK SPI CLOCK OUT2B SPI CLOCK Programmable power supply (Max 30mA load) LI M2S Digital IO SCL I2C communication Digital supply used for I2C devices VDDA_S Sensing Supply Device A Sensing Output 1 Device A Sensing Output 1 Device A Sensing Output 2 Device A VDDB_S Sensing Supply Device A Sensing Supply Device B OUT1B_Sensing Output 1 Device B Sensing Output 2 Device B DUT1B_Sensing Output 1 Device B Sensing Output 2 Device B DUT1B_Sensing Output 1 Device B Sensing Output 2 Device B DUT1B_Sensing Output 2 Device B Sensing Output 1 Device B DUT1B_Sensing Output 2 Device B DUT1B_Sensing Output 2 Device B Sensing Output 1 Device B DUT1B_Sensing Output 2 Device B DUT1B_Sensing Output 3 Device B DUT1B_Sensing Output 4 Device B DUT1B_Sensing Output 5 Device B DUT1B_Sensing Output 6 Device B DUT1B_Sensing Output 7 Device B DUT1B_Sensing Output 9 D	Pin	Names	SPI	Description	Pin	Pin	Pin
OUT2A MISO Output 2 Device A 4 3 13 VSSA VSS Analog Ground Device A (Minimum required single die connection) 2 8 2 VDDB Supply Device B (Minimum required dual die connection 1) 13 OUT1B SS1 Output 1 Device B (Minimum required dual die connection 1) 7 OUT2B SS2 Output 2 Device B (Minimum required dual die connection) 7 OUT2B SS2 Output 2 Device B (Minimum required dual die connection) 10 CLK SPI CLOCK OUT2B SS2 Output 2 Device B (Minimum required dual die connection) 10 CLK SPI CLOCK DUT2B SS2 Digital IO 12 SCL 12C communication 12 I2C communication 13 +5Vdig Digital supply used for 12C devices 14 VDDA_S Sensing Supply Device A 1 5 15 15 15 15 15 15 15 15 15 15 15 15	1	VDDA	VDD	Supply Device A (Minimum required single die connection)	3	1	3
4 VSSA VSS Analog Ground Device A (Minimum required single die connection) 2 8 2 5 VDDB Supply Device B (Minimum required dual die connection) 12 6 OUT1B SS1 Output 1 Device B (Minimum required dual die connection) 7 7 OUT2B SS2 Output 2 Device B 5 8 VSSB Analog Ground Device B (Minimum required dual die connection) 10 9 CLK SPI CLOCK 10 10 V_BAT Programmable power supply (Max 30mA load) 11 M2S Digital IO 12 SCL 12C communication 13 +5Vdig Digital supply used for I2C devices 14 VDDA_S Sensing Supply Device A 3 1 3 15 OUT1A_ Sensing Output 1 Device A 1 5 15 16 OUT2A_ Sensing Analog Ground Device A 2 8 2 17 VSSA_S Sensing Output 1 Device B 1 1 19 OUT1B_ Sensing Output 2 Device B 5 20 OUT2	2	OUT1A	MOSI	Output 1 Device A (Minimum required single die connection)	1	5	15
Supply Device B (Minimum required dual die connection 4) OUT1B SS1 Output 1 Device B (Minimum required dual die connection) OUT2B SS2 Output 2 Device B NSSB Analog Ground Device B (Minimum required dual die connection) CLK SPI CLOCK Programmable power supply (Max 30mA load) M2S Digital IO SCL I2C communication SCL I2C communication JSCL I2C communication Sensing Supply Device A Sensing Output 1 Device A Supply Device A Sensing Output 1 Device A Supply Device A Sensing Output 2 Device A Supply Device B Supply De	3	OUT2A	MISO	Output 2 Device A	4	3	13
6 OUT1B SS1 Output 1 Device B (Minimum required dual die connection) 7 7 OUT2B SS2 Output 2 Device B 5 8 VSSB Analog Ground Device B (Minimum required dual die connection) 10 9 CLK SPI CLOCK 10 V_BAT Programmable power supply (Max 30mA load) 11 M2S Digital IO 12 SCL I2C communication 13 +5Vdig Digital supply used for I2C devices 14 VDDA_S Sensing Supply Device A 3 1 3 15 OUT1A_ Sensing Output 1 Device A 1 5 5 15 S Sensing Output 2 Device A 4 3 13 17 VSSA_S Sensing Analog Ground Device A 2 8 2 18 VDDB_S Sensing Supply Device B 12 19 OUT2B_ Sensing Output 1 Device B 5 S Sensing Output 1 Device B 5 S Sensing Output 2 Device B 5 S Sensing Output 3 Device B 5 S Sensing Output 3 Device B 5 S Sensing Output 4 Device B 5 S Sensing Output 5 Device B 5 S Sensing Output 6 Device B 6 7 S Sensing Output 6 Device B 7 S Sensing Output 7 Device B 7 S Sensing Output 8 Device B 7 S Sensing Output 9 Device 9 8 S Sensing Output 9 Device 9 8 S Sensing Output 9 Device 9 8 S	4	VSSA	VSS	Analog Ground Device A (Minimum required single die connection)	2	8	2
7 OUT2B SS2 Output 2 Device B 8 VSSB Analog Ground Device B (Minimum required dual die connection) 9 CLK SPI CLOCK 10 V_BAT Programmable power supply (Max 30mA load) 11 M2S Digital IO 12 SCL I2C communication 13 +5Vdig Digital supply used for I2C devices 14 VDDA_S Sensing Supply Device A 3 1 3 15 OUT1A_Sensing Output 1 Device A S 16 OUT2A_Sensing Output 2 Device A S 17 VSSA_S Sensing Analog Ground Device A 2 8 2 18 VDDB_S Sensing Supply Device B S 20 OUT2B_Sensing Output 2 Device B S 21 VSSB_S Sensing Analog Ground Device B S 22 DB_TEST Free measuring line Digital IO	5	VDDB		Supply Device B (Minimum required dual die connection ⁴)			11
8 VSSB Analog Ground Device B (Minimum required dual die connection) 9 CLK SPI CLOCK 10 V_BAT Programmable power supply (Max 30mA load) 11 M2S Digital IO 12 SCL I2C communication 13 +5Vdig Digital supply used for I2C devices 14 VDDA_S Sensing Supply Device A 3 1 3 15 OUT1A_ Sensing Output 1 Device A 1 5 15 S 16 OUT2A_ Sensing Output 2 Device A 4 3 13 S 17 VSSA_S Sensing Analog Ground Device A 2 8 2 18 VDDB_S Sensing Supply Device B 13 19 OUT1B_ Sensing Output 1 Device B S 20 OUT2B_ Sensing Output 2 Device B S 21 VSSB_S Sensing Analog Ground Device B S 22 DB_TEST Free measuring line 23 S2M Digital IO	6	OUT1B	SS1	Output 1 Device B (Minimum required dual die connection)			7
9 CLK SPI CLOCK 10 V_BAT Programmable power supply (Max 30mA load) 11 M2S Digital IO 12 SCL I2C communication 13 +5Vdig Digital supply used for I2C devices 14 VDDA_S Sensing Supply Device A 15 OUT1A_ Sensing Output 1 Device A 16 OUT2A_ Sensing Output 2 Device A 17 VSSA_S Sensing Analog Ground Device A 18 VDDB_S Sensing Supply Device B 19 OUT1B_ Sensing Output 1 Device B 20 OUT2B_ Sensing Output 2 Device B 21 VSSB_S Sensing Analog Ground Device B 22 DB_TEST 23 S2M Digital IO	7	OUT2B	SS2	Output 2 Device B			5
10 V_BAT Programmable power supply (Max 30mA load) 11 M2S Digital IO 12 SCL I2C communication 13 +5Vdig Digital supply used for I2C devices 14 VDDA_S Sensing Supply Device A 3 1 3 15 OUT1A_ Sensing Output 1 Device A 1 5 19 S 16 OUT2A_ Sensing Output 2 Device A 4 3 13 S 17 VSSA_S Sensing Analog Ground Device A 2 8 2 18 VDDB_S Sensing Supply Device B 12 19 OUT1B_ Sensing Output 1 Device B 7 S 20 OUT2B_ Sensing Output 2 Device B 5 S 21 VSSB_S Sensing Analog Ground Device B 5 S 22 DB_TEST Free measuring line 5 S2M Digital IO	8	VSSB		Analog Ground Device B (Minimum required dual die connection)			10
11 M2S Digital IO 12 SCL I2C communication 13 +5Vdig Digital supply used for I2C devices 14 VDDA_S Sensing Supply Device A 3 1 3 15 OUT1A_ Sensing Output 1 Device A 1 5 1! S 16 OUT2A_ Sensing Output 2 Device A 4 3 1: S 17 VSSA_S Sensing Analog Ground Device A 2 8 2 18 VDDB_S Sensing Supply Device B 1: Sensing Output 1 Device B 7 S 20 OUT2B_ Sensing Output 2 Device B 5 S 21 VSSB_S Sensing Analog Ground Device B 5 S 22 DB_TEST Free measuring line 52M Digital IO	9		CLK	SPI CLOCK			
12 SCL I2C communication 13 +5Vdig Digital supply used for I2C devices 14 VDDA_S Sensing Supply Device A 3 1 3 15 OUT1A_ Sensing Output 1 Device A 1 5 1! S 16 OUT2A_ Sensing Output 2 Device A 4 3 1! S 17 VSSA_S Sensing Analog Ground Device A 2 8 2 18 VDDB_S Sensing Supply Device B 1! 19 OUT1B_ Sensing Output 1 Device B 7 S 20 OUT2B_ Sensing Output 2 Device B 5 S 21 VSSB_S Sensing Analog Ground Device B 10 22 DB_TEST Free measuring line 5 23 S2M Digital IO	10	V_BAT		Programmable power supply (Max 30mA load)			
13 +5Vdig Digital supply used for I2C devices 14 VDDA_S Sensing Supply Device A 3 1 3 15 OUT1A_ Sensing Output 1 Device A 1 5 1! S 16 OUT2A_ Sensing Output 2 Device A 4 3 1: S 17 VSSA_S Sensing Analog Ground Device A 2 8 2 18 VDDB_S Sensing Supply Device B 1: 19 OUT1B_ Sensing Output 1 Device B 7 S 20 OUT2B_ Sensing Output 2 Device B 5 S 21 VSSB_S Sensing Analog Ground Device B 10 22 DB_TEST Free measuring line 10 23 S2M Digital IO	11	M2S		Digital IO			
14VDDA_SSensing Supply Device A31315OUT1A_ SSensing Output 1 Device A151!16OUT2A_ SSensing Output 2 Device A431:17VSSA_SSensing Analog Ground Device A28218VDDB_SSensing Supply Device B1:19OUT1B_ SSensing Output 1 Device B720OUT2B_ SSensing Output 2 Device B521VSSB_SSensing Analog Ground Device B1022DB_TESTFree measuring line23S2MDigital IO	12	SCL		I2C communication			
15 OUT1A_ Sensing Output 1 Device A 1 5 19 16 OUT2A_ Sensing Output 2 Device A 4 3 19 17 VSSA_S Sensing Analog Ground Device A 2 8 2 18 VDDB_S Sensing Supply Device B 19 19 OUT1B_ Sensing Output 1 Device B 7 19 Sensing Output 2 Device B 5 20 OUT2B_ Sensing Output 2 Device B 5 21 VSSB_S Sensing Analog Ground Device B 10 22 DB_TEST Free measuring line 10 23 S2M Digital IO	13	+5Vdig		Digital supply used for I2C devices			
S 16 OUT2A_ Sensing Output 2 Device A 4 3 13 S 17 VSSA_S Sensing Analog Ground Device A 2 8 2 18 VDDB_S Sensing Supply Device B 12 19 OUT1B_ Sensing Output 1 Device B 7 S 20 OUT2B_ Sensing Output 2 Device B 5 S 21 VSSB_S Sensing Analog Ground Device B 10 22 DB_TEST Free measuring line 23 S2M Digital IO	14	VDDA_S		Sensing Supply Device A	3	1	3
S 17 VSSA_S Sensing Analog Ground Device A 18 VDDB_S Sensing Supply Device B 19 OUT1B_ Sensing Output 1 Device B S 20 OUT2B_ Sensing Output 2 Device B S 21 VSSB_S Sensing Analog Ground Device B 22 DB_TEST Free measuring line 23 S2M Digital IO	15	_		Sensing Output 1 Device A	1	5	15
18 VDDB_S Sensing Supply Device B 19 OUT1B_ Sensing Output 1 Device B 20 OUT2B_ Sensing Output 2 Device B S 21 VSSB_S Sensing Analog Ground Device B 22 DB_TEST Free measuring line 23 S2M Digital IO	16	_		Sensing Output 2 Device A	4	3	13
19 OUT1B_ Sensing Output 1 Device B 7 S 20 OUT2B_ Sensing Output 2 Device B 5 S 21 VSSB_S Sensing Analog Ground Device B 10 22 DB_TEST Free measuring line 23 S2M Digital IO	17	VSSA_S		Sensing Analog Ground Device A	2	8	2
S 20 OUT2B_ Sensing Output 2 Device B S 21 VSSB_S Sensing Analog Ground Device B 22 DB_TEST Free measuring line 23 S2M Digital IO	18	VDDB_S		Sensing Supply Device B			11
S 21 VSSB_S Sensing Analog Ground Device B 22 DB_TEST Free measuring line 23 S2M Digital IO	19	_		Sensing Output 1 Device B			7
22 DB_TEST Free measuring line 23 S2M Digital IO	20	_		Sensing Output 2 Device B			5
23 S2M Digital IO	21	VSSB_S		Sensing Analog Ground Device B			10
	22	DB_TEST		Free measuring line			
0.4	23	S2M		Digital IO			
24 SDA I2C communication	24	SDA		I2C communication			
25 DGND Digital ground for I2C communication	25	DGND		Digital ground for I2C communication			
MH AGND Metal Housing (shielding of the connector)	MH	AGND		Metal Housing (shielding of the connector)			

⁴ In case of a dual die connection with a common supply in the application (common VDD), only the VDDA pin of the daughter board device connector needs to be connected.

Daughter Board for Melexis PTC devices



PTC0	4			90380		
D-SU	B 25			DMP	SO	TSSOP
Pin	Names	SPI	Description	Pin	Pin	Pin
1	VDDA	VDD	Supply Device A (Minimum required single die connection)	2	6/7	14/15
2	OUT1A	MOSI	Output 1 Device A (Minimum required single die connection)	3	8	16
3	OUT2A	MISO	Output 2 Device A	1	5	13
4	VSSA	VSS	Analog Ground Device A (Minimum required single die connection)	4	1	1
5	VDDB		Supply Device B (Minimum required dual die connection ⁵)			6/7
6	OUT1B	SS1	Output 1 Device B (Minimum required dual die connection)			8
7	OUT2B	SS2	Output 2 Device B			5
8	VSSB		Analog Ground Device B (Minimum required dual die connection)			9
9		CLK	SPI CLOCK			
10	V_BAT		Programmable power supply (Max 30mA load)			
11	M2S		Digital IO			
12	SCL		I2C communication			
13	+5Vdig		Digital supply used for I2C devices			
14	VDDA_S		Sensing Supply Device A	2	6/7	14/15
15	OUT1A_S		Sensing Output 1 Device A	3	8	16
16	OUT2A_S		Sensing Output 2 Device A	1	5	13
17	VSSA_S		Sensing Analog Ground Device A	4	1	1
18	VDDB_S		Sensing Supply Device B			6/7
19	OUT1B_S		Sensing Output 1 Device B			8
20	OUT2B_S		Sensing Output 2 Device B			5
21	VSSB_S		Sensing Analog Ground Device B			9
22	DB_TEST		Free measuring line			
23	S2M		Digital IO			
24	SDA		I2C communication			
25	DGND		Digital ground for I2C communication			
МН	AGND		Metal Housing (shielding of the connector)			

⁵ In case of a dual die connection with a common supply in the application (common VDD), only the VDDA pin of the daughter board device connector needs to be connected.



1.5. Jumper Selection

1.5.1. CON18 and CON19 – short measuring lines

The D-SUP DB-25 connector of the daughter board is equipped with a sensing line for each analog device pin.

The top row is the force line of the device pins. The bottom row is the sensing line of the device pins.

Between each force and sense line there is a jumper to short the sense line at the DB-25 connector on the daughter board.

The jumper is placed when the external sensing is not required. For example: an application with a digital or PWM output.

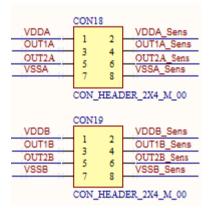
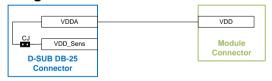


Figure 14: Jumper between force and sense line.

Single wire connection



When the jumper is closed, only one wire is required **per pin** between the PTC-04 and the module or sensor.

In the table above these pins are marked as "Minimum required single/dual die connection".

In this configuration the measurement of VDD, OUT1 or OUT2 is done at the D-SUB DB-25 connector of the PTC04-DB-HALL06.

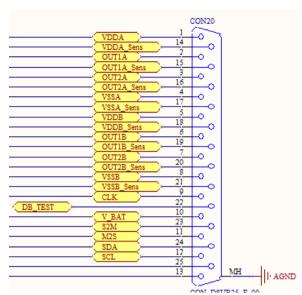


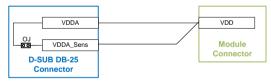
Figure 15: DB-25 device connector.

CON18 and CON19 are used to short the force and sense line of the analog device pins.

In other words, they are used to select single wire or double wire connection to the pin of the module / sensor.

- CON18 → Device / Die A
- CON19 → Device / Die B

Double wire connection



When the jumper is open, two wires are required **per pin** between the PTC-04 and the module or sensor.

With two wires connected at the module side, the measurement of VDD, OUT1 or OUT2 is done on the module or sensor connector.

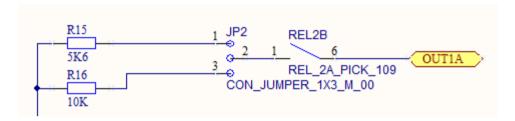
The external sensing line per pin is only required for applications with an analog sensor output and where a higher measuring accuracy is required.



1.5.2. J2, J3, J4 and J5 – select pull-up

These jumpers are used to select the pull-up resistor for the outputs of die A and B:

- JP2: Pull-up selection for OUT1 die A
- JP3: Pull-up selection for OUT2 die A
- JP4: Pull-up selection for OUT1 die B
- JP5: Pull-up selection for OUT2 die B



Place the jumper between:

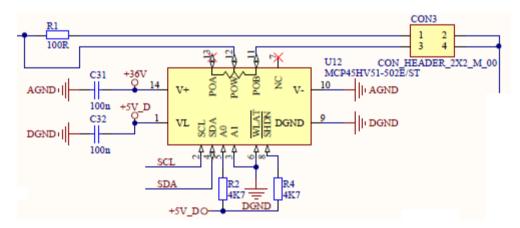
- Pin 1 and 2 → select 5K6 Pull-up
- Pin 3 and 2 → select 10K Pull-up

The selection between VDD and Vbat is done by a relay on software level. When Vbat is set to 0V one can select a pull-down

1.5.3. CON3 and CON21 – configure MUPeT circuit

The MUPeT circuit on the daughter board is used to convert the clock and data of the UART to a single wire protocol called MUPeT.

CON3 and CON21 are used to configure the resistors of the MUPeT circuit in function of the output resistance on the sensor/module.



- Pin 1 and 2 \rightarrow select 100 Ω
- Pin 3 and 4 → select digital potentiometer

PTC04-DB-HALL06

Daughter Board for Melexis PTC devices



2. Contact

For the latest version of this document, go to our website at www.melexis.com. For additional information, please contact our Direct Sales team and get help for your specific needs:

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PTC04-DB-HALL06



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